Spectral Lines

WWW.SCVEMC.Org Santa Clara Valley Chapter of IEEE Electromagnetic Compatibility Society

April 2001 issue

SCV EMC Society Meeting "RADIATED EMISSIONS MEASUREMENTS ABOVE 1 GHz" Tuesday, April 10, 2001

The April meeting of the Santa Clara Valley EMC Society will be held at SGI in Mountain View, 1600 Amphitheatre Pkwy., building 40, in the Presentation Center above the lobby. The social gathering will start at 5:30 PM, and food and drinks will be available. **The technical presentation will start at 7:00 PM.** A map with the location of the SGI campus is available in this newsletter.

RADIATED EMISSIONS MEASUREMENTS ABOVE 1 GHZ

Radiated field strength measurements at frequencies above 1 GHz are becoming common requirements for a wider range of equipment than ever before. In addition to case radiated measurements from licensed transmitters, and restricted band emissions from FCC Part 15 devices and for ISM equipment, ITE equipment is now included as one of the categories requiring testing to microwave frequencies. The current 1GHz microprocessors and the 2 GHz processors in development are pushing testing requirements up to the 5 - 10 GHz range.

The presentation will review the regulations requiring measurements above 1 GHz for ITE and other types of equipment. Specialized test equipment, such as horn antennas, boresight antenna masts, low loss flexible coaxial cables, and harmonic mixers will be discussed.

There will also be discussion of test methodology. Published test procedures often lack the level of detail that is necessary to make repeatable and accurate measurements. The narrow beam widths of the measurement antennas and the highly directional nature of the emissions require careful search procedures to accurately measure maximum field strengths, and slight differences in technique can result in level measurements that can differ by more than 10 dB.

BIO

Tom Cokenias has been in the RF regulatory field for over 25 years. He spent 8 years working as an electronic engineer in the Equipment Authorization Branch of the FCC Laboratory in Columbia, MD. Since 1983 has held senior engineering positions at a number of EMC laboratories in the Bay area, most recently as Director of Engineering at Compliance Certification Services. He is also owner and chief consultant at T.N. Cokenias Consulting in El Granada, CA.

Anyone interested in presenting an outline of EMC-related topics should contact Tom Cokenias (trephonc@macconnect.com) at 650-726-1263.

For more information about the newsletter and its distribution, please contact the editor Neven Pischl (npischl@cisco.com) at 408-527-7874.

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$$\nabla \times \vec{\mathbf{E}} = -\frac{\partial \vec{\mathbf{B}}}{\partial t}$$
$$\nabla \times \vec{\mathbf{H}} = \frac{\partial \vec{\mathbf{D}}}{\partial t} + \vec{\mathbf{J}}$$
$$\nabla \cdot \vec{\mathbf{D}} = \rho$$

$$\nabla \cdot \vec{B} = 0$$

SCV-CHAPTER OF THE IEEE EMC SOCIETY MEETING, 10 APRIL 2001



MEETING TIME: Social – 5:30 PM Presentation - 7:00 PM

Dated Material - Meeting Notice Address Service Requested **Spectral Lines**

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